

Notice of References Cited	Application/Control No. 09/995,577		Applicant(s)/Patent Under Reexamination WATANABE, TOSHIYUKI	
	Examiner HELEN SHIBRU		Art Unit 2621	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0065969	05-2002	Schultz, Mark Alan	710/260
*	B	US-6,320,826	11-2001	Willis et al.	369/30.1
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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